

L Number	Hits	Search Text	DB	Time stamp
1	1	ink adj serialized adj format	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 14:46
14	4699	((digital adj ink) or (electronic ink)) adj2 structure	USPAT; US-PGPUB	2004/06/12 15:31
15	3	((digital adj ink) or (electronic adj ink)) adj2 structure	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 15:31
-	1322	(ink adj (data or object\$1)) or (electronic adj ink)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 14:37
-	68454	data adj structure\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:42
-	12945	file adj format\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:49
-	755	((data adj structure\$1) or (file adj format\$1)) with (table\$1) with (index\$2 or indices)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:53
-	2	((ink adj (data or object\$1)) or (electronic adj ink)) and (((data adj structure\$1) or (file adj format\$1)) with (table\$1) with (index\$2 or indices))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:50
-	750	(data adj structure\$1) with (table\$1) with (index\$2 or indices)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:53
-	94	((data adj structure\$1) with (table\$1) with (index\$2 or indices)) and (382/\$ or 345/\$ or 178/\$).ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:16
-	18	((data adj structure\$1) with (table\$1) with (index\$2 or indices)) and (707/104.1.ccls.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:22
-	1	((file adj format\$1) with (table\$1) with (index\$2 or indices)) and (382/\$ or 345/\$ or 178/\$ or 707/104.1).ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:19
-	5	((file adj format\$1) with (table\$1) with (index\$2 or indices))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:19
-	162	((data adj structure\$1) adj8 (table\$1) adj8 (index\$2 or indices))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:23
-	10	((data adj structure\$1) adj8 (table\$1) adj8 (index\$2 or indices))	EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:23

-	1326	((ink adj (data or object\$1)) or (electronic adj ink)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:49
-	38	((ink adj (data or object\$1)) or (electronic adj ink)) near6 (query or search\$3 or retriev\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:50
-	28	((ink adj (data or object\$1)) or (electronic adj ink)) with ((data adj structure\$1) or (file adj format\$1))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:51
-	58	((ink adj (data or object\$1)) or (electronic adj ink)) near6 (query or search\$3 or retriev\$3) or (((ink adj (data or object\$1)) or (electronic adj ink)) with ((data adj structure\$1) or (file adj format\$1)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/10 13:51

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(file format) <and> table* <and> index*
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